

**Search Notes**

Application/Control No.

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Examiner

Tam M. Nguyen

Applicant(s)/Patent under  
Reexamination

BOUDREAU ET AL.

Art Unit

1764

**SEARCHED**

Class	Subclass	Date	Examiner
585	UPDATED	9/6/2004	TN
208	UPDATED	9/6/2004	TN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
585	809		
	850		
208	223	9/6/2004	TN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR